



**EXPEDITED PROCEDURE - EXAMINING GROUP 2818**

**09/808,750**

#9  
Response  
PATENT  
1/11/03

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Applicant:	Huy Thanh Vo	Examiner:	Son Mai
Serial No.:	09/808,750	Group Art Unit:	2818
Filed:	March 15, 2001	Docket:	303.723US1
Title:	DEVICE AND METHOD TO REDUCE WORDLINE RC TIME CONSTANT IN SEMICONDUCTOR MEMORY DEVICES		

**AMENDMENT & RESPONSE UNDER 37 C.F.R. § 1.116**

Box AF  
Commissioner for Patents  
Washington, D.C. 20231

**IN THE DRAWINGS**

Corrected drawings are supplied herewith.

**REMARKS**

Applicant has carefully reviewed and considered the Office Action mailed on October 18, 2002, and the references cited therewith.

No claims are amended or cancelled. Claims 1-54 remain pending in this application.

**§102 Rejection of the Claims**

Claims 1-54 were rejected under 35 USC § 102(b) as being anticipated by Tanoi (U.S. Patent No. 5,708,621).

The rejection states that, "Tanoi discloses . . . a strapping line (118 in fig. 16) of lower resistance than the wordlines coupled to a single wordline, wherein the strapping line bypasses a portion of the single wordline."

The Examiner's response to Applicant's arguments from the previous Amendment and Response states that, "On the contrary, as pointed out in the above rejections, Tanoi shows at least in one embodiment in figures 16-18, two channels (interconnecting plugs 122, 126) connecting a strapping line 118 to two ends of a portion of a single wordline." The Examiner's response to Applicant's arguments further states that, "Tanoi shows in Figure 4, the strapping